Application/Control No. Applicant(s)/Patent Under Reexamination TANAKA ET AL. Examiner Barbara Gilliam Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
	N	JP 01-133044	05-1989	Japan	Uchino et al.	G03C 1/00		
	0	JP 11-352670 A	12-1999	Japan	Hiroshi et al.	G03F 7/00		
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